

<b>Notice of References Cited</b>	Application/Control No. 10/625,823		Applicant(s)/Patent Under Reexamination GOLDTHWAITE ET AL.	
	Examiner Christian A. Hannon		Art Unit 2618	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0213849	11-2003	Luu, Daniel V. H.	235/492
*	B	US-6,771,981	08-2004	Zalewski et al.	455/557
*	C	US-2002/0047045	04-2002	Song et al.	235/441
*	D	US-2004/0242208	12-2004	Teicher, Mordechai	455/414.1
*	E	US-2004/0058705	03-2004	Morgan et al.	455/556.1
*	F	US-2004/0077372	04-2004	Halpern, John W.	455/550.1
*	G	US-2004/0180657	09-2004	Yaqub et al.	455/435.1
*	H	US-2003/0018587	01-2003	Althoff et al.	705/64
*	I	US-5,880,769	03-1999	Nemirofsky et al.	725/139
*	J	US-6,955,299	10-2005	Pathmasuntharan et al.	235/492
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO0186599a2	11-2001	IL	Landman et al	G07F 7/00
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.